

# RF Power LDMOS Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

These high ruggedness devices are designed for use in high VSWR military, aerospace and defense, industrial (including laser and plasma exciters), broadcast (analog and digital), and radio/land mobile applications. They are unmatched input and output designs allowing wide frequency range utilization, between 1.8 and 600 MHz.

- Typical Performance:  $V_{DD} = 50$  Vdc,  $I_{DQ} = 100$  mA

Signal Type	$P_{out}$ (W)	f (MHz)	$G_{ps}$ (dB)	$\eta_D$ (%)	IRL (dB)
Pulse (100 $\mu$ sec, 20% Duty Cycle)	600 Peak	230	25.0	74.6	-18
CW	600 Avg.	230	24.6	75.2	-17

- Capable of Handling a Load Mismatch of 65:1 VSWR @ 50 Vdc, 230 MHz, at all Phase Angles, Designed for Enhanced Ruggedness
  - 600 W Pulse Peak Power, 20% Duty Cycle, 100  $\mu$ sec

### Features

- Unmatched Input and Output Allowing Wide Frequency Range Utilization
- Device can be used Single-Ended or in a Push-Pull Configuration
- Qualified Up to a Maximum of 50  $V_{DD}$  Operation
- Characterized from 30 V to 50 V for Extended Power Range
- Suitable for Linear Application with Appropriate Biasing
- Integrated ESD Protection with Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- In Tape and Reel. R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel.

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +133	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	$^{\circ}$ C
Case Operating Temperature	$T_C$	150	$^{\circ}$ C
Total Device Dissipation @ $T_C = 25^{\circ}$ C Derate above 25 $^{\circ}$ C	$P_D$	1667 8.33	W W/ $^{\circ}$ C
Operating Junction Temperature (1,2)	$T_J$	225	$^{\circ}$ C

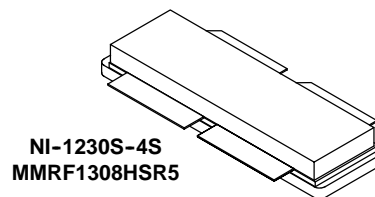
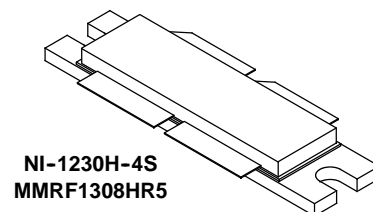
**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 68 $^{\circ}$ C, 600 W Peak, 100 $\mu$ sec Pulse Width, 20% Duty Cycle, 100 mA, 230 MHz Case Temperature 60 $^{\circ}$ C, 600 W CW, 100 mA, 230 MHz	$Z_{\theta JC}$ $R_{\theta JC}$	0.022 0.12	$^{\circ}$ C/W

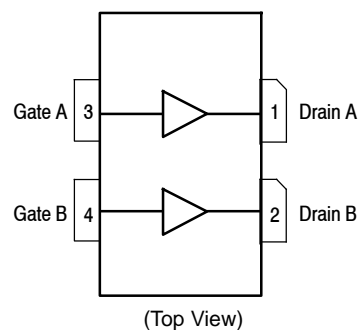
- Continuous use at maximum temperature will affect MTTF.
- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
- Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

## MMRF1308HR5 MMRF1308HSR5

1.8-600 MHz, 600 W CW, 50 V  
BROADBAND  
RF POWER MOSFETs



PARTS ARE PUSH-PULL



Note: The backside of the package is the source terminal for the transistors.

**Figure 1. Pin Connections**

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	2
Machine Model (per EIA/JESD22-A115)	B
Charge Device Model (per JESD22-C101)	IV

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

**Off Characteristics (1)**

Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$
Drain-Source Breakdown Voltage ( $V_{GS} = 0\text{ Vdc}$ , $I_D = 100\text{ mA}$ )	$V_{(BR)DSS}$	133	—	—	Vdc
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 50\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 100\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	20	$\mu\text{Adc}$

**On Characteristics**

Gate Threshold Voltage (1) ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 960\ \mu\text{Adc}$ )	$V_{GS(th)}$	1.7	2.2	2.7	Vdc
Gate Quiescent Voltage ( $V_{DD} = 50\text{ Vdc}$ , $I_D = 100\text{ mA}$ , Measured in Functional Test)	$V_{GS(Q)}$	2.0	2.5	3.0	Vdc
Drain-Source On-Voltage (1) ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 2\text{ Adc}$ )	$V_{DS(on)}$	—	0.26	—	Vdc

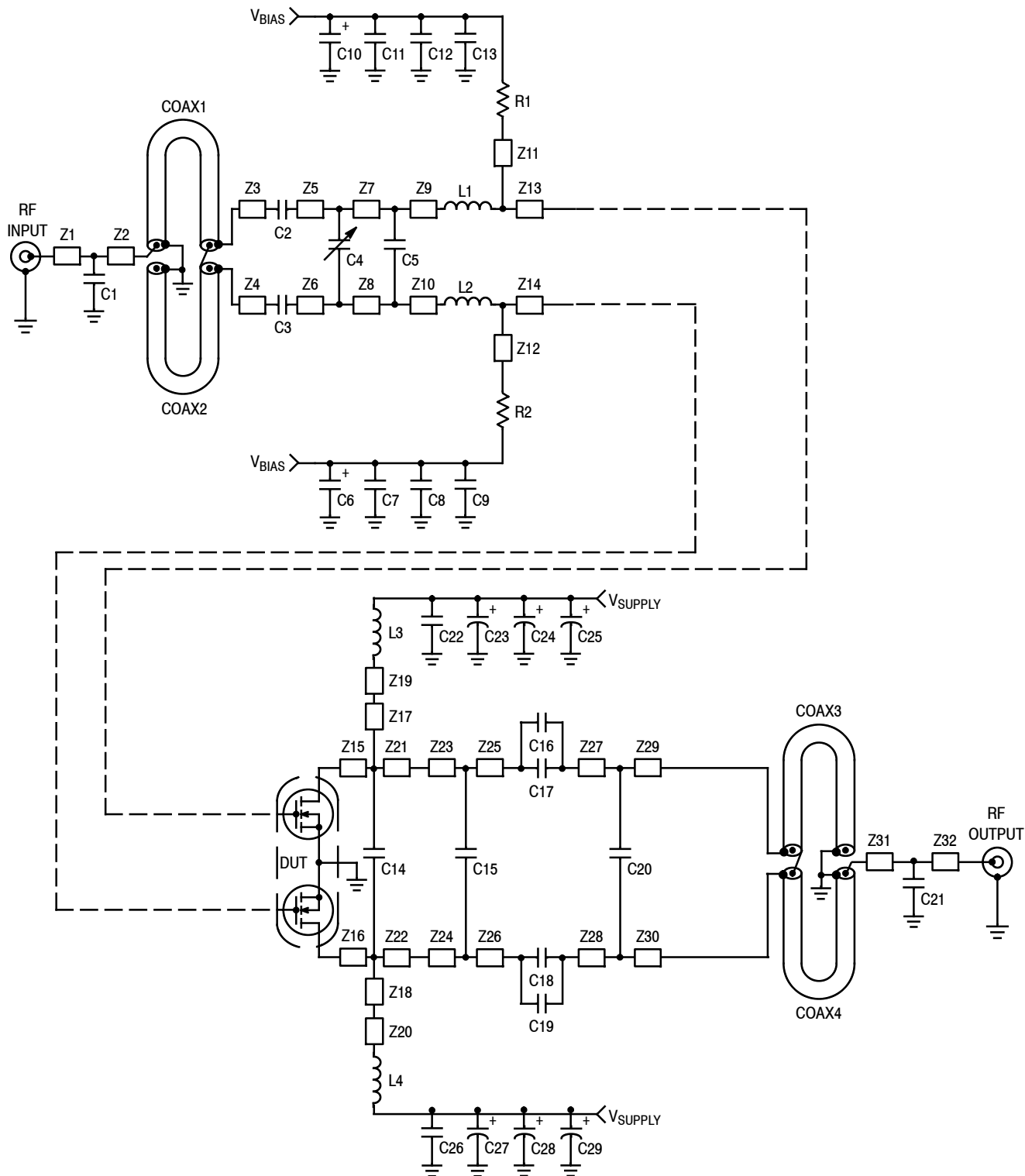
**Dynamic Characteristics (1)**

Reverse Transfer Capacitance ( $V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{rss}$	—	1.60	—	pF
Output Capacitance ( $V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{oss}$	—	129	—	pF
Input Capacitance ( $V_{DS} = 50\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)	$C_{iss}$	—	342	—	pF

**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 50\text{ Vdc}$ ,  $I_{DQ} = 100\text{ mA}$ ,  $P_{out} = 600\text{ W Peak}$  (120 W Avg.),  $f = 230\text{ MHz}$ , 100  $\mu\text{sec}$  Pulse Width, 20% Duty Cycle

Power Gain	$G_{ps}$	23.5	25.0	26.5	dB
Drain Efficiency	$\eta_D$	73.5	74.6	—	%
Input Return Loss	IRL	—	-18	-12	dB

1. Each side of device measured separately.



Z1	0.192" x 0.082" Microstrip	Z11*, Z12*	0.872" x 0.058" Microstrip	Z23, Z24	1.251" x 0.300" Microstrip
Z2	0.175" x 0.082" Microstrip	Z13, Z14	0.412" x 0.726" Microstrip	Z25, Z26	0.127" x 0.300" Microstrip
Z3, Z4	0.170" x 0.100" Microstrip	Z15, Z16	0.371" x 0.507" Microstrip	Z27, Z28	0.058" x 0.300" Microstrip
Z5, Z6	0.116" x 0.285" Microstrip	Z17*, Z18*	0.466" x 0.363" Microstrip	Z29, Z30	0.058" x 0.300" Microstrip
Z7, Z8	0.116" x 0.285" Microstrip	Z19*, Z20*	1.187" x 0.154" Microstrip	Z31	0.186" x 0.082" Microstrip
Z9, Z10	0.108" x 0.285" Microstrip	Z21, Z22	0.104" x 0.507" Microstrip	Z32	0.179" x 0.082" Microstrip

\* Line length includes microstrip bends

Figure 2. MMRF1308HR5(HSR5) Test Circuit Schematic - Pulse

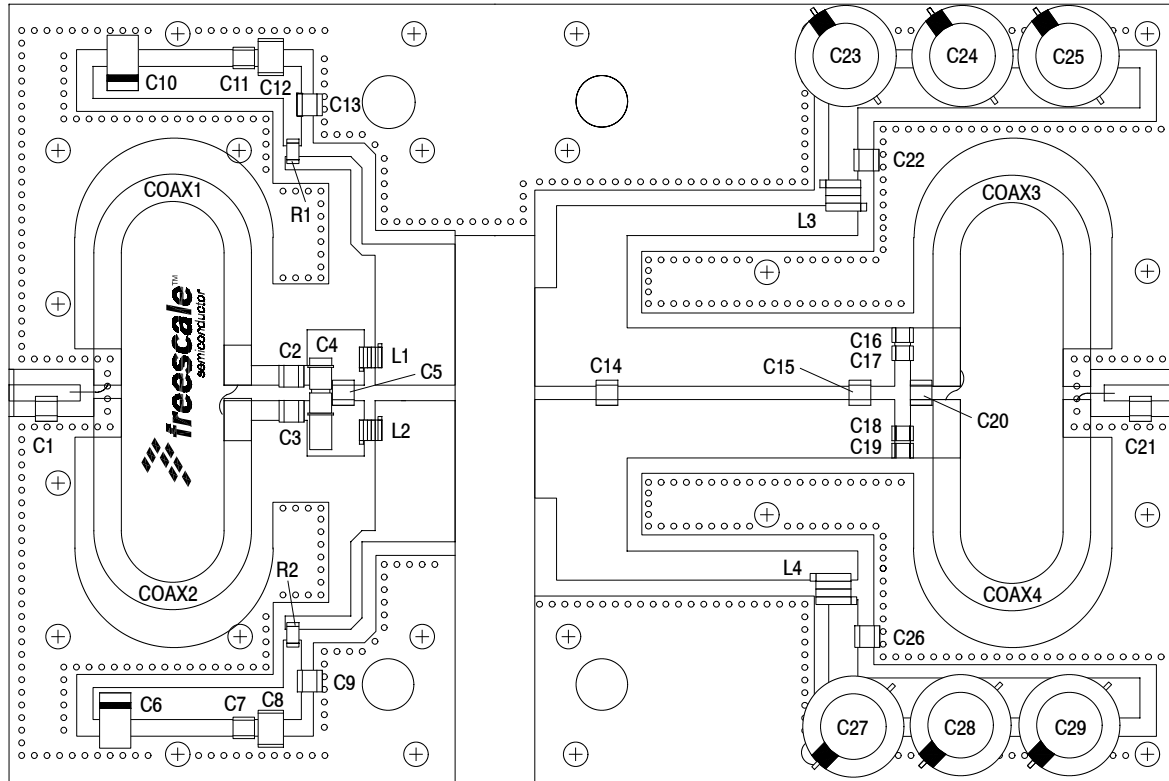
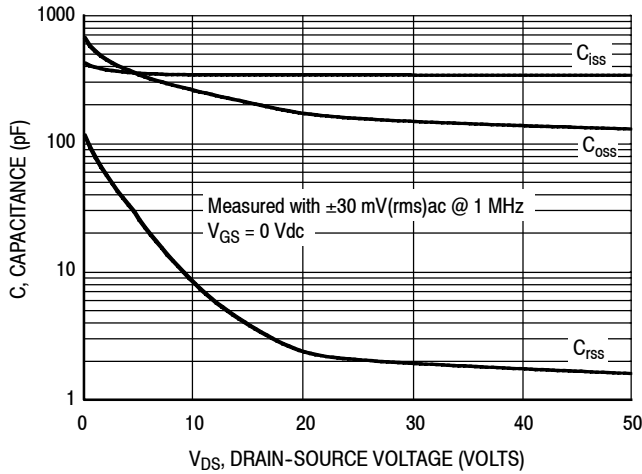


Figure 3. MMRF1308HR5(HSR5) Test Circuit Component Layout - Pulse

Table 5. MMRF1308HR5(HSR5) Test Circuit Component Designations and Values - Pulse

Part	Description	Part Number	Manufacturer
C1	12 pF Chip Capacitor	ATC100B120JT500XT	ATC
C2, C3	27 pF Chip Capacitors	ATC100B270JT500XT	ATC
C4	0.8–8.0 pF Variable Capacitor, Gigatrim	27291SL	Johanson
C5	33 pF Chip Capacitor	ATC100B330JT500XT	ATC
C6, C10	22 $\mu$ F, 35 V Tantalum Capacitors	T491X226K035AT	Kemet
C7, C11	0.1 $\mu$ F Chip Capacitors	CDR33BX104AKYS	AVX
C8, C12	220 nF Chip Capacitors	C1812C224K5RACTU	Kemet
C9, C13, C22, C26	1000 pF Chip Capacitors	ATC100B102JT50XT	ATC
C14	36 pF Chip Capacitor	ATC100B360JT500XT	ATC
C15	51 pF Chip Capacitor	ATC100B510GT500XT	ATC
C16, C17, C18, C19	240 pF Chip Capacitors	ATC100B241JT200XT	ATC
C20	39 pF Chip Capacitor	ATC100B390JT500XT	ATC
C21	10 pF Chip Capacitor	ATC100B100JT500XT	ATC
C23, C24, C25, C27, C28, C29	470 $\mu$ F, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
Coax1, 2, 3, 4	25 $\Omega$ Semi Rigid Coax, 2.2" Shield Length	UT-141C-25	Micro Coax
L1, L2	5 nH Inductors	A02TKLC	Coilcraft
L3, L4	6.6 nH Inductors	GA3093-ALC	Coilcraft
R1, R2	10 $\Omega$ Chip Resistors	CRCW120610R0JNEA	Vishay
PCB	0.030", $\epsilon_r = 2.55$	AD255A	Arlon

## TYPICAL CHARACTERISTICS



Note: Each side of device measured separately.

Figure 4. Capacitance versus Drain-Source Voltage

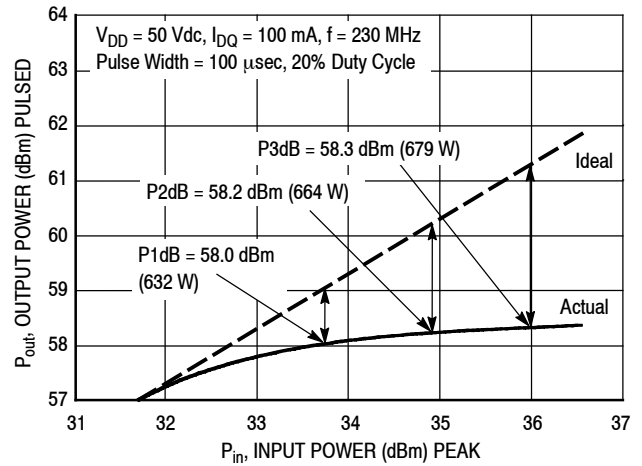


Figure 5. Output Power versus Input Power

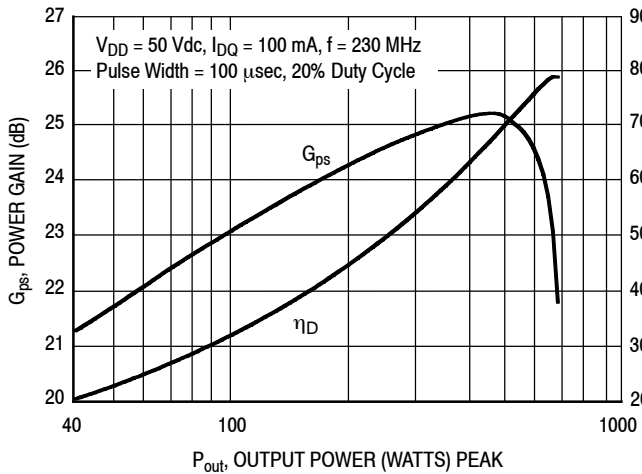


Figure 6. Power Gain and Drain Efficiency versus Output Power

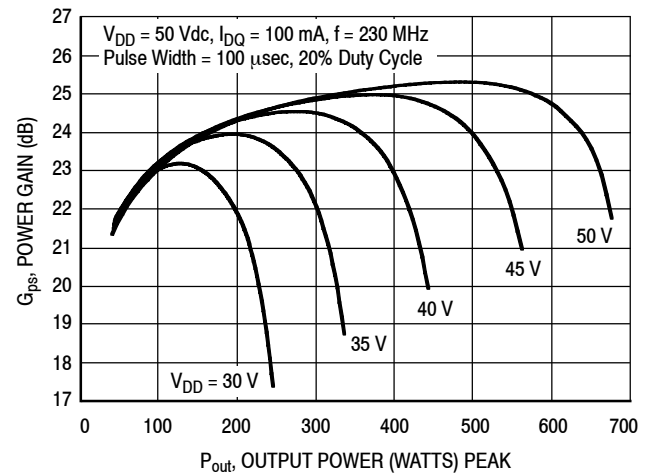


Figure 7. Power Gain versus Output Power

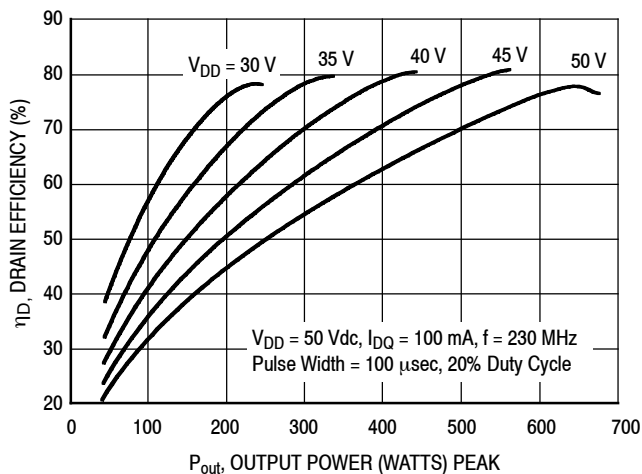


Figure 8. Drain Efficiency versus Output Power

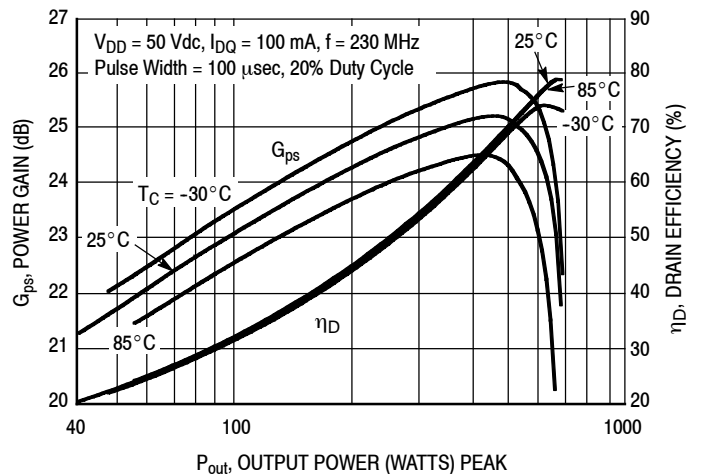
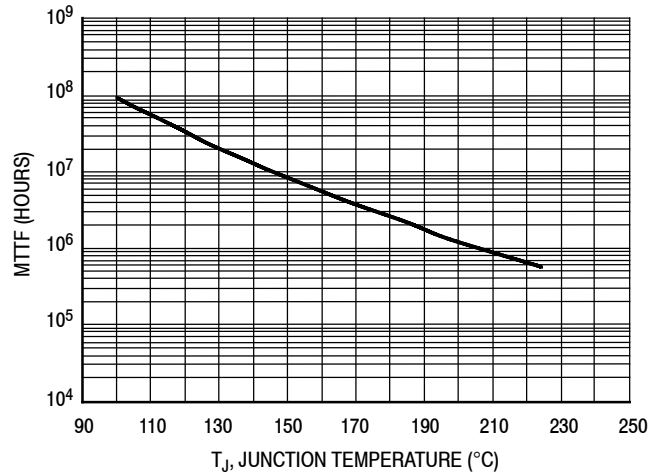


Figure 9. Power Gain and Drain Efficiency versus Output Power

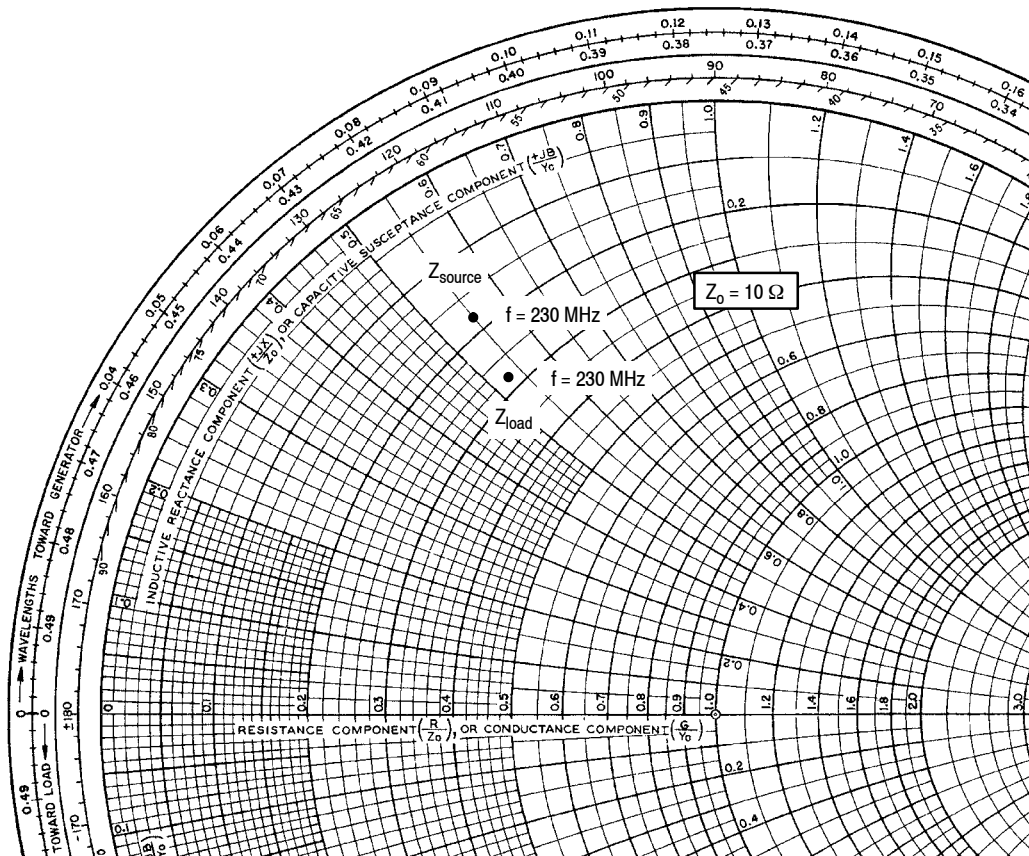
## TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours when the device is operated at  $V_{DD} = 50$  Vdc,  $P_{out} = 600$  W Avg., and  $\eta_D = 75.2\%$ .

MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

**Figure 10. MTTF versus Junction Temperature — CW**



$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQ} = 100 \text{ mA}$ ,  $P_{out} = 600 \text{ W Peak}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
230	$1.78 + j5.45$	$2.75 + j5.30$

$Z_{source}$  = Test circuit impedance as measured from gate to gate, balanced configuration.

$Z_{load}$  = Test circuit impedance as measured from drain to drain, balanced configuration.

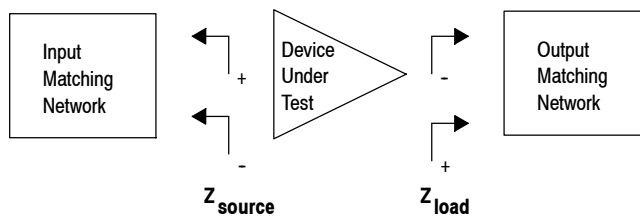
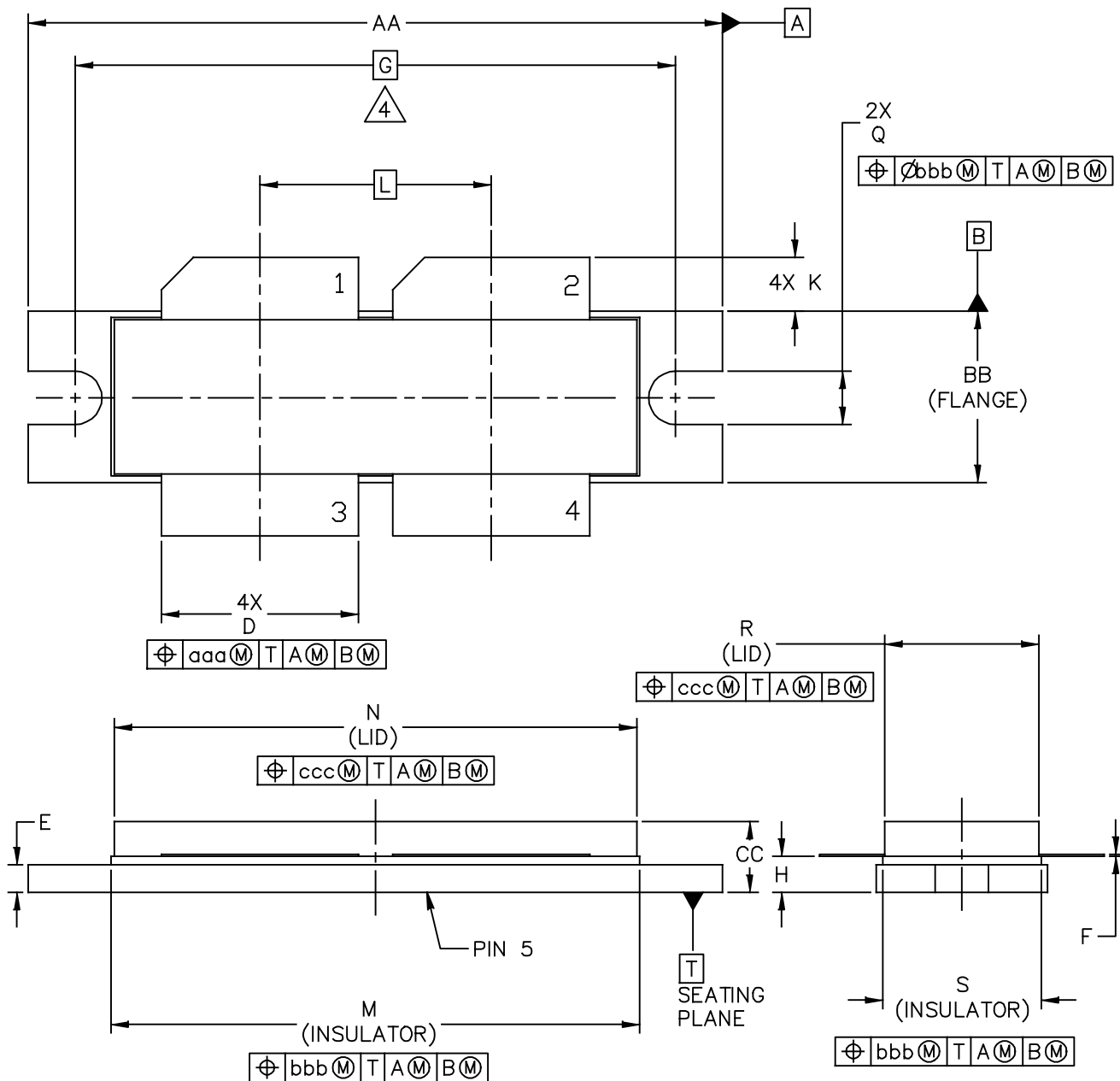


Figure 11. Series Equivalent Source and Load Impedance

### PACKAGE DIMENSIONS



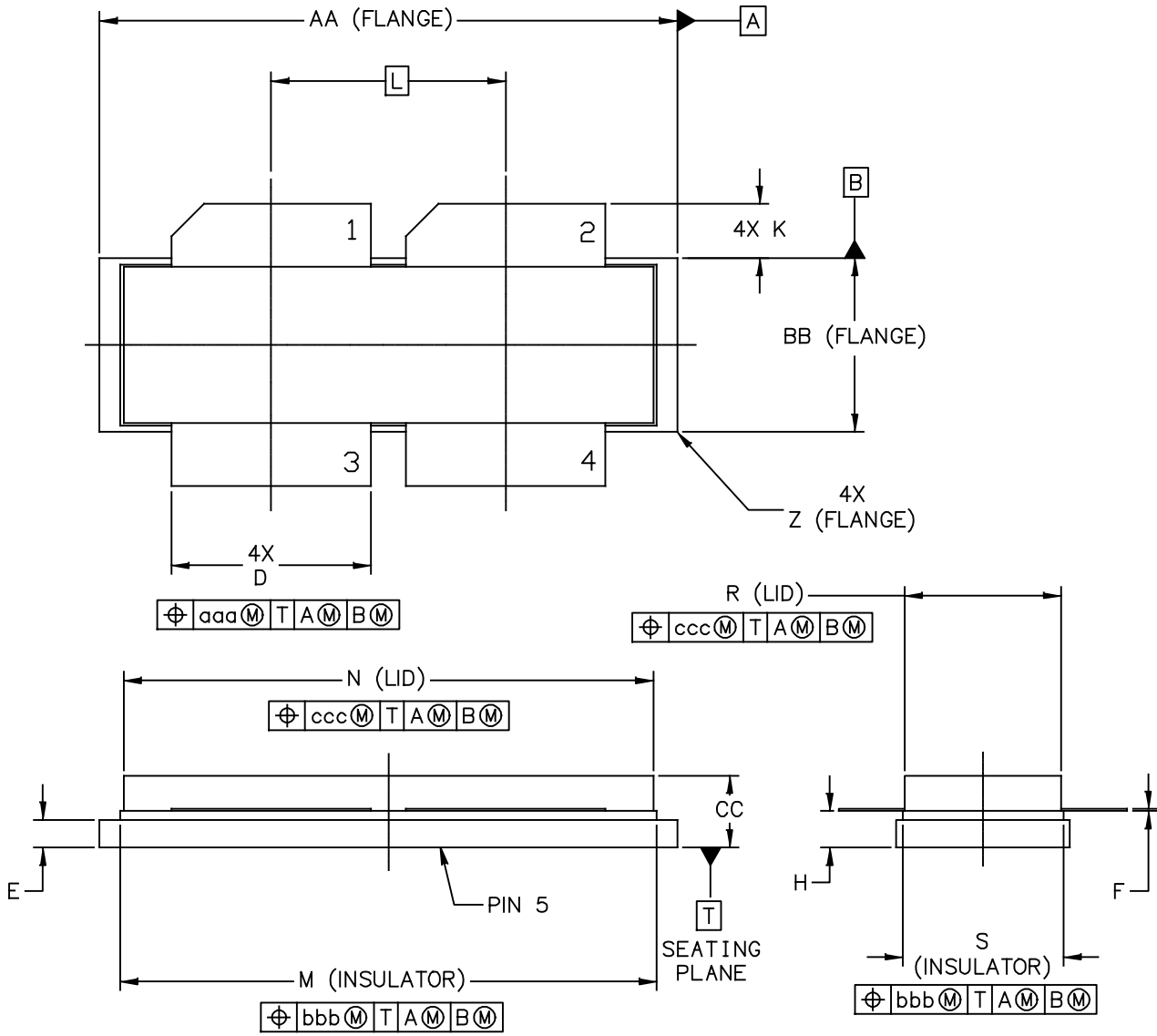
© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE
TITLE:  NI-1230-4H	DOCUMENT NO: 98ASB16977C STANDARD: NON-JEDEC	REV: F
		28 FEB 2013



NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY.
4. RECOMMENDED BOLT CENTER DIMENSION OF 1.52 INCH (38.61 MM) BASED ON M3 SCREW.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	1.615	1.625	41.02	41.28	N	1.218	1.242	30.94	31.55
BB	.395	.405	10.03	10.29	Q	.120	.130	3.05	3.30
CC	.170	.190	4.32	4.83	R	.355	.365	9.02	9.27
D	.455	.465	11.56	11.81	S	.365	.375	9.27	9.53
E	.062	.066	1.57	1.68					
F	.004	.007	0.10	0.18					
G	1.400 BSC		35.56 BSC		aaa	.013		0.33	
H	.082	.090	2.08	2.29	bbb	.010		0.25	
K	.117	.137	2.97	3.48	ccc	.020		0.51	
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					
© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.			MECHANICAL OUTLINE			PRINT VERSION NOT TO SCALE			
TITLE:					DOCUMENT NO: 98ASB16977C      REV: F				
NI-1230-4H					STANDARD: NON-JEDEC				
					28 FEB 2013				



© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE
TITLE:  NI-1230-4S	DOCUMENT NO: 98ARB18247C	REV: G
	STANDARD: NON-JEDEC	
	01 MAR 2013	

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY

DIM	INCHES		MILLIMETERS		DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	1.265	1.275	32.13	32.39	R	.355	.365	9.02	9.27
BB	.395	.405	10.03	10.29	S	.365	.375	9.27	9.53
CC	.170	.190	4.32	4.83	Z	R.000	R.040	R0.00	R1.02
D	.455	.465	11.56	11.81					
E	.062	.066	1.57	1.68	aaa	.013		0.33	
F	.004	.007	0.10	0.18	bbb	.010		0.25	
H	.082	.090	2.08	2.29	ccc	.020		0.51	
K	.117	.137	2.97	3.48					
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					
N	1.218	1.242	30.94	31.55					
© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.			MECHANICAL OUTLINE			PRINT VERSION NOT TO SCALE			
TITLE:					DOCUMENT NO: 98ARB18247C		REV: G		
NI-1230-4S					STANDARD: NON-JEDEC				
					01 MAR 2013				

## PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	July 2014	• Initial Release of Data Sheet